CUSTOMER:	
DESCRIPTION:	SAW RESONATOR SMD3.8*3.8 433.92MHz
MANUFACTURER PART NO.:	FTR433.92M75-SM38-FI
CUSTOMER PART NO:	
USED IN MODEL:	

# 1. Scope:

This specification shall cover the characteristics of 1-port SAW resonator with R433.92M used for remote-control security.

# 2. Electrical Specification:

### 2.1 Maximum Rating

DC Voltage VDC	10V
AC Voltage Vpp	10V 50Hz/60Hz
Operation temperature	-40°C to +85°C
Storage temperature	-45°C to +85°C
Max Input Power	0dBm

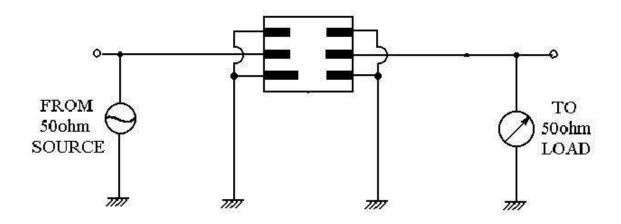
### 2.2 Electronic Characteristics

Test Temperature:  $25^{\circ}C \pm 2^{\circ}C$ 

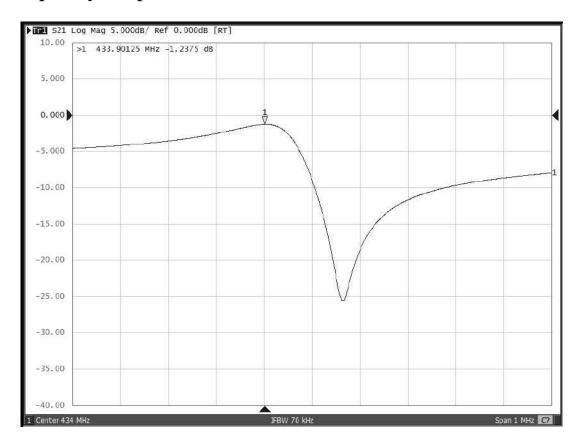
Terminating source impedance:  $50\Omega$  Terminating load impedance:  $50\Omega$ 

	ltem:		Minimum	Typical	Maximum	Unit
Center Frequency	Absolute Frequency	fc	433.845	433.920	433.995	MHz
	Tolerance from 433.920MHz	△fc		±75		KHz
Insertion Loss		IL		1.5	2.5	dB
Quality Factor	Unloaded Q	Qυ	1000	5000		
	50Ω Loaded Q	QL	500	1000		
Temperature	Turnover Temperature	T <sub>0</sub>	10	25	40	$^{\circ}$
Stability	Frequency Temperature Coefficient	FTC		0.032		ppm/℃
Frequency Aging	Absolute Value during the First Year	f <sub>A</sub>		≤±10		ppm/yr
DC Insulation R	esistance		1.0			МΩ
RF	Motional Resistance	R <sub>M</sub>		20	26	Ω
Equivalent RLC	Motional Inductance	L <sub>M</sub>		65.605		μH
Model	Motional Capacitance	См		2.0504		fF
Transducer Stat	ic Capacitance	С		2.8		pF

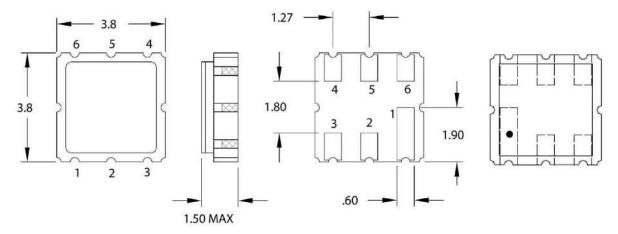
# 3. Test Circuit:



# 4. Frequency Response:



# 5. Dimension:

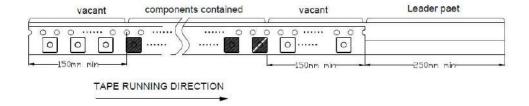


Pin Configuration

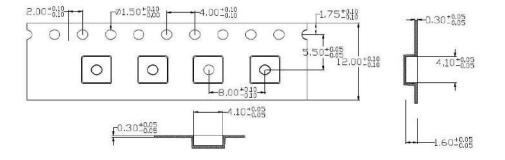
2	Input
5	Output
1, 3, 4, 6	To Be Ground

### **Packing Information**

# Carrier Tape

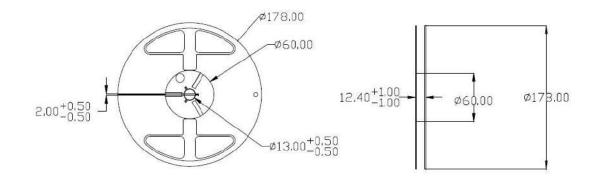


Unit: mm

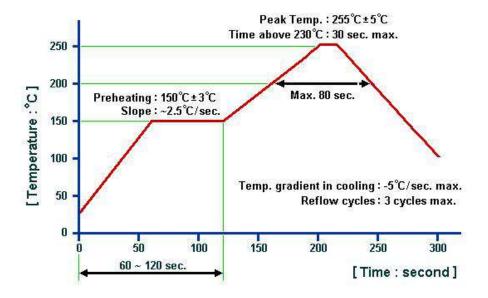


Unit: mm

### **Reel Dimensions**



# Recommended Soldering Profile



### 6. Environment Characteristic:

#### 5-1 High temperature exposure

Subject the device to +85 °C for 16 hours. Then release the filter into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 2-2.

### 5-2 Low temperature exposure

Subject the device to -40 °C for 16 hours. Then release the device into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 2-2.

#### 5-3 Temperature cycling

Subject the device to a low temperature of -40  $^{\circ}$ C for 30 minutes. Following by a high temperature of +85  $^{\circ}$ C for 30 Minutes. Then release the device into the room conditions for 24 hours prior to the measurement. It shall meet the specifications in 2-2.

#### 5-4 Resistance to solder heat

Dip the device terminals no closer than 1.5mm into the solder bath at  $260^{\circ}\text{C} \pm 10^{\circ}\text{C}$  for  $10\pm1$  sec. Then release the device into the room conditions for 4 hours. The device shall meet the specifications in 2-2.

#### 5-5 Solderability

Subject the device terminals into the solder bath at  $245^{\circ}$ C  $\pm 5^{\circ}$ C for 5s, More than 95% area of the terminals must be covered with new solder. It shall meet the specifications in 2-2.

### 5-6 Mechanical shock

Drop the device randomly onto the concrete floor from the height of 1m 3 times. the device shall fulfill the specifications in 2-2.

#### 5-7 Vibration

Subject the device to the vibration for 1 hour each in x,y and z axes with the amplitude of 1.5 mm at 10 to 55 Hz. The device shall fulfill the specifications in 2-2.